## Application/Control No. Applicant(s)/Patent Under Reexamination 10/720,030 HEISHI ET AL. Notice of References Cited Art Unit Examiner Page 1 of 1 Daniel Pan 2183 **U.S. PATENT DOCUMENTS** Document Number Date Name Classification Country Code-Number-Kind Code MM-YYYY US-5,448,746 09-1995 Eickemeyer et al. 712/210 Α US-5,452,461 09-1995 Umekita et al. 717/149 В US-С US-D US-Ε US-F US-G US-Н US-US-J US-Κ US-US-M FOREIGN PATENT DOCUMENTS Document Number Date Country Name Classification Country Code-Number-Kind Code MM-YYYY Ν 0 Р Q R s Т **NON-PATENT DOCUMENTS** Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) U W

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